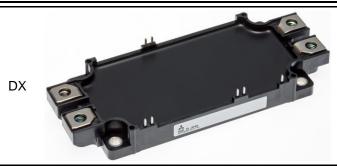


<IGBT Modules>

## CM600DX-24T1/CM600DXP-24T1

HIGH POWER SWITCHING USE **INSULATED TYPE** 



Collector current Ic ..... Maximum junction temperature T<sub>vjmax</sub> ....... 175°C

- Flat base type
- Copper base plate (Nickel-plating)
- •RoHS Directive compliant
- Tin-plating pin terminals



Collector current Ic ..... Maximum junction temperature T<sub>vimax</sub> ........ 1 7 5 °C

- Flat base type
- Copper base plate (Nickel-plating)
- RoHS Directive compliant
- Tin-plating pressfit terminals
- •UL Recognized under UL1557, File No. E323585

#### **APPLICATION**

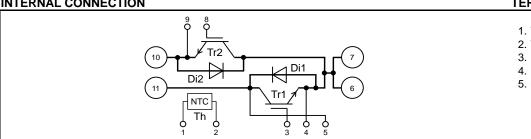
AC Motor Control, Motion/Servo Control, Power supply, etc.

dual switch (half-bridge)

#### **OPTION** (Below options are available.)

- •PC-TIM (Phase Change Thermal Interface Material) pre-apply
- V<sub>CEsat</sub> selection for parallel connection

#### **INTERNAL CONNECTION**



#### **TERMINAL CODE**

1. TH1 6. C2E1 2. TH2 7. C2E1 3. G1 8. G2 4. Es1 9. Es2 5. Cs1 10. E2 11. C1

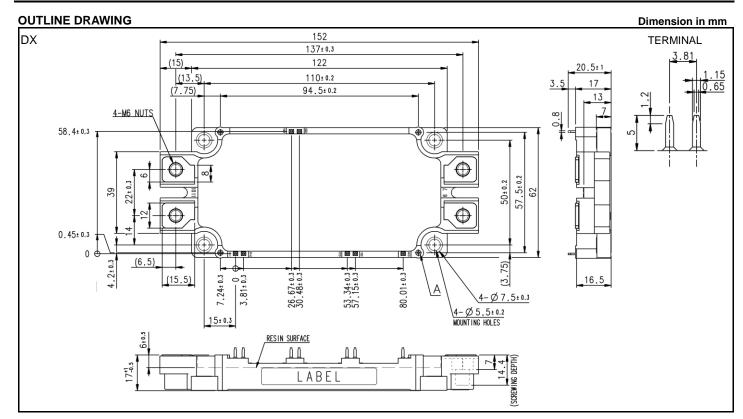
## **OUTLINE DRAWING** Dimension in mm MOUNTING HOLES **SECTION A** COM. Ø2.6 Ø2.32 $\oplus$

1

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HIGH POWER SWITCHING USE

INSULATED TYPE

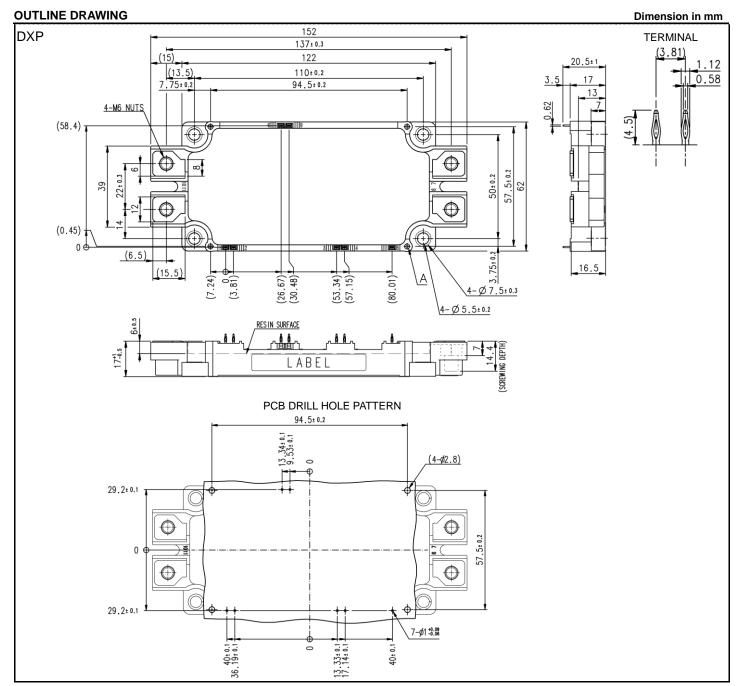


Tolerance otherwise specified

Divisio	n of	Tolerance				
	0.5	to	3	±0.2		
over	3	to	6	±0.3		
over	6	to	30	±0.5		
over	30	to	120	±0.8		
over 120		to 400		±1.2		

HIGH POWER SWITCHING USE

INSULATED TYPE



Tolerance otherwise specified

Divisio	n of I	Tolerance					
	0.5	to	3	±0.2			
over 3		to	6	±0.3			
over	6	to	30	±0.5			
over	30	to 120		±0.8			
over 120		to 400		±1.2			

HIGH POWER SWITCHING USE

INSULATED TYPE

#### MAXIMUM RATINGS ( $T_{vj}$ =25 °C, unless otherwise specified)

### INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Rating	Unit
V <sub>CES</sub>	Collector-emitter voltage	G-E short-circuited	1200	V
V <sub>GES</sub>	Gate-emitter voltage	C-E short-circuited	± 20	V
Ic	Collector current	DC, T <sub>C</sub> =86 °C (Note2, 4)	600	۸
I <sub>CRM</sub>	Collector current	Pulse, Repetitive (Note3)	1200	Α
P <sub>tot</sub>	Total power dissipation	T <sub>C</sub> =25 °C (Note2, 4)	2500	W
I <sub>E</sub> (Note1)	Emitter eugraph	DC (Note2)	600	۸
I <sub>ERM</sub> (Note1)	Emitter current	Pulse, Repetitive (Note3)	1200	Α

#### **MODULE**

Symbol	Item	Conditions		Unit
V <sub>isol</sub>	Isolation voltage Terminals to base plate, RMS, f=60 Hz, AC 1 min		2500	V
$T_{vjmax}$	Maximum junction temperature	Instantaneous event (overload)	175	°C
T <sub>Cmax</sub>	Maximum case temperature	(Note4)	125	C
T <sub>vjop</sub>	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T <sub>stq</sub>	Storage temperature	-	-40 ~ +125	C

## ELECTRICAL CHARACTERISTICS (T $_{vj}$ =25 °C, unless otherwise specified) INVERTER PART IGBT/FWD

Cumbal	Itom	Conditions		Limits			Unit
Symbol	Item	Conditions			Тур.	Max.	Unit
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited			-	1.0	mA
I <sub>GES</sub>	Gate-emitter leakage current	V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited		-	-	0.5	μΑ
$V_{GE(th)}$	Gate-emitter threshold voltage	Ic=60 mA, VcE=10 V		5.4	6.0	6.6	V
V <sub>CEsat</sub>		I <sub>C</sub> =600 A, V <sub>GE</sub> =15 V,	T <sub>vj</sub> =25 °C	-	1.90	2.25	
		Refer to the figure of test circuit	T <sub>vj</sub> =125 °C	-	2.15	-	V
(Terminal)	Callantar are the restriction walter	(Note5)	T <sub>vj</sub> =150 °C	-	2.25	-	
	Collector-emitter saturation voltage	Ic=600 A,	T <sub>vj</sub> =25 °C	-	1.70	2.00	
V <sub>CEsat</sub>		V <sub>GE</sub> =15 V,	T <sub>vj</sub> =125 °C	-	1.95	-	V
(Chip)		(Note5)	T <sub>vj</sub> =150 °C	-	2.05	-	
Cies	Input capacitance			-	-	109.1	
Coes	Output capacitance	V <sub>CE</sub> =10 V, G-E short-circuited	-	-	3.1	nF	
Cres	Reverse transfer capacitance	1		-	-		1.4
Q <sub>G</sub>	Gate charge	V <sub>CC</sub> =600 V, I <sub>C</sub> =600 A, V <sub>GE</sub> =15 V		-	3.4	-	μC
t <sub>d(on)</sub>	Turn-on delay time	V 200 V I 200 A V 45 V		-	-	600	- ns
tr	Rise time	V <sub>CC</sub> =600 V, I <sub>C</sub> =600 A, V <sub>GE</sub> =±15 V,	-	-	300		
t <sub>d(off)</sub>	Turn-off delay time	$R_G$ =1.0 $\Omega$ , Inductive load		-	-	800	
t <sub>f</sub>	Fall time			-	-	400	
(Noted)		I <sub>E</sub> =600 A, G-E short-circuited,	T <sub>vj</sub> =25 °C	-	1.90	2.35	
V <sub>EC</sub> (Note1)		Refer to the figure of test circuit	T <sub>vj</sub> =125 °C	<sub>vj</sub> =125 °C - 1.95		-	V
(Terminal)	Facilities and light states and light	(Note5)	T <sub>vj</sub> =150 °C	-	2.00	-	1
(Noted)	- Emitter-collector voltage	I <sub>E</sub> =600 A,	T <sub>vj</sub> =25 °C	-	1.75	2.10	V
V <sub>EC</sub> (Note1)		G-E short-circuited,	T <sub>vj</sub> =125 °C	-	1.80	-	
(Chip)		(Note5)	T <sub>vj</sub> =150 °C	-	1.80	-	
t <sub>rr</sub> (Note1)	Reverse recovery time	V <sub>CC</sub> =600 V, I <sub>E</sub> =600 A, V <sub>GE</sub> =±15 V,		-	-	400	ns
Q <sub>rr</sub> (Note1)	Reverse recovery charge	$R_G=1.0 \Omega$ , Inductive load	4		46.8	-	μC
Eon	Turn-on switching energy per pulse	V <sub>CC</sub> =600 V, I <sub>C</sub> =I <sub>E</sub> =600 A,		-	53.0	-	m l
E <sub>off</sub>	Turn-off switching energy per pulse	$V_{GE}$ =±15 V, $R_{G}$ =1.0 $\Omega$ , $T_{vj}$ =150 °C,	-	56.0	-	mJ	
E <sub>rr</sub> (Note1)	Reverse recovery energy per pulse	Inductive load		-	40.0	-	mJ
R <sub>CC'+EE'</sub>	Internal lead resistance	Main terminals-chip, per switch, T <sub>C</sub> =29	5 °C (Note4)	-	0.75	-	mΩ
r <sub>g</sub>	Internal gate resistance	Per switch		-	0.67	-	Ω

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HIGH POWER SWITCHING USE

INSULATED TYPE

#### ELECTRICAL CHARACTERISTICS (cont.; Tvj=25 °C, unless otherwise specified)

#### NTC THERMISTOR PART

Symbol	Item	Conditions		Unit		
	item	Conditions	Min.	Тур.	Max.	Offic
R <sub>25</sub>	Zero-power resistance T <sub>C</sub> =25 °C (Note4)		4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R <sub>100</sub> =493 Ω, T <sub>C</sub> =100 °C (Note4)	-7.3	-	+7.8	%
B <sub>(25/50)</sub>	B-constant Approximate by equation (Note6)		-	3375	-	K
P <sub>25</sub>	Power dissipation	T <sub>C</sub> =25 °C (Note4)	-	-	10	mW

#### THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions			Unit		
Symbol	item			Min.	Тур.	Max.	Offic
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)		-	-	60	K/kW
$R_{th(j-c)D}$	Thermatresistance	Junction to case, per Inverter FWD (Note4)		-	-	87	N/KVV
В	Contact thermal resistance	Case to heat sink,	ase to heat sink, Thermal grease applied (Note4, 7)		11.5	-	K/kW
$R_{th(c-s)}$		per 1 module,	PC-TIM applied (Note4, 8)	-	3.1	-	r/KVV

#### MECHANICAL CHARACTERISTICS

Company of	lt	0.00		I lait			
Symbol	Item	Con	Conditions			Max.	Unit
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N⋅m
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m
		Coldennia tuno (DV)	Terminal to terminal	17	-	-	- mm
. ا	Creepage distance	Solder pin type (DX)	Terminal to base plate	16.4	-	-	
ds		Pressfit pin type (DXP)	Terminal to terminal	17	-	-	mm
			Terminal to base plate	16.8	-	-	
		Solder pin type (DX)	Terminal to terminal	10	-	-	mm
. ا			Terminal to base plate	16.2	-	-	
d <sub>a</sub>	Clearance	Dragofit win town (DVD)	Terminal to terminal	10	-	-	
		Pressfit pin type (DXP)  Terminal to base plate		16.2	-	-	mm
ес	Flatness of base plate	On the centerline X, Y	Note9)	±0	-	+200	μm
m	mass	-		-	300	-	g

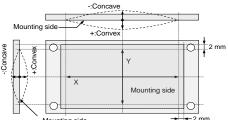
- \*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.
- Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).
  - 2. Junction temperature  $(T_{vj})$  should not increase beyond  $T_{vjmax}$  rating.
  - 3. Pulse width and repetition rate should be such that the device junction temperature (Tvj) dose not exceed Tvjmax rating.
  - 4. Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>S</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
  - 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. 
$$B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$$

R<sub>25</sub>: resistance at absolute temperature T<sub>25</sub> [K]; T<sub>25</sub>=25 [°C]+273.15=298.15 [K]

 $R_{50}$ : resistance at absolute temperature  $T_{50}$  [K];  $T_{50}$ =50 [°C]+273.15=323.15 [K]

- 7. Typical value is measured by using thermally conductive grease of  $\lambda$ =0.9 W/(m·K)/D<sub>(C-S)</sub>=50  $\mu$ m.
- 8. Typical value is measured by using PC-TIM of  $\lambda$ =3.4 W/(m·K)/D<sub>(C-S)</sub>=50  $\mu$ m.
- 9. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



#### <IGBT Modules>

## CM600DX-24T1/CM600DXP-24T1

HIGH POWER SWITCHING USE

#### INSULATED TYPE

Note10. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

PCB thickness : t=1.6

	Туре	Manufacturer	Size	Tightening torque (N•m)	Recommended tightening method
(1)	PT®	EJOT	K25×8	0.55 ± 0.055	
(2)	PT®		K25×10	0.75 ± 0.075 N·m	by handwork (equivalent to 30 r/min
(3)	DELTA PT®		25×8	0.55 ± 0.055 N·m	by mechanical screw driver)
(4)	DELTA PT®		25×10	0.75 ± 0.075 N·m	~ 600 r/min (by mechanical screw driver)
(5)	B1	-	φ2.6×10	0.75 ± 0.075 N·m	
	tapping screw		φ2.6×12	0.75 ± 0.075 N-III	

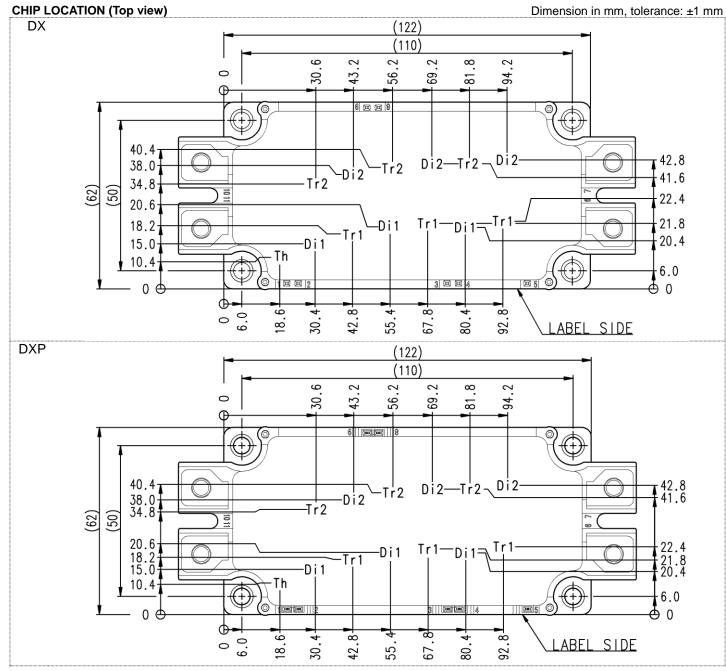
#### RECOMMENDED OPERATING CONDITIONS

Symbol	Itom	Conditions		Linit		
Symbol	Item	Conditions	Min.	Тур.	Max.	Unit
Vcc	(DC) Supply voltage	Applied across C1-E2 terminals	-	600	850	V
$V_{GEon}$	Gate (-emitter drive) voltage	Applied across G1-E1s/G2-E2s terminals	13.5	15.0	16.5	V
R <sub>G</sub>	External gate resistance	Per switch	1.0	-	6.8	Ω

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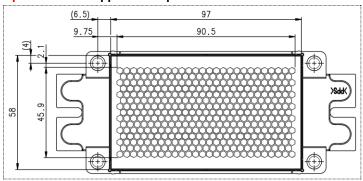
HIGH POWER SWITCHING USE

**INSULATED TYPE** 



Tr1/Tr2: IGBT, Di1/Di2: FWD, Th: NTC thermistor

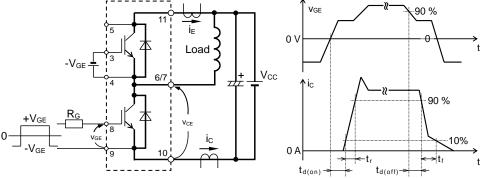
#### **Option: PC-TIM applied baseplate outline**

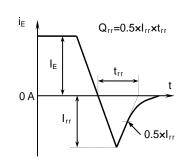


HIGH POWER SWITCHING USE

INSULATED TYPE

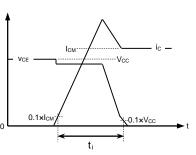
#### **TEST CIRCUIT AND WAVEFORMS**

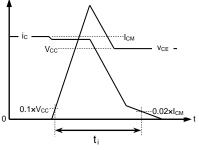


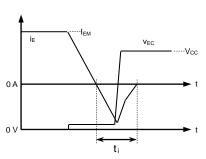


Switching characteristics test circuit and waveforms

trr, Qrr characteristics test waveform







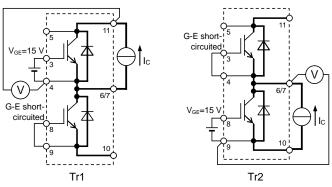
IGBT Turn-on switching energy

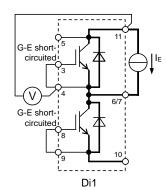
IGBT Turn-off switching energy

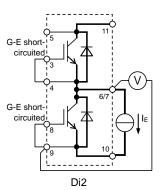
FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

#### **TEST CIRCUIT**







V<sub>CEsat</sub> characteristics test circuit

V<sub>EC</sub> characteristics test circuit

HIGH POWER SWITCHING USE

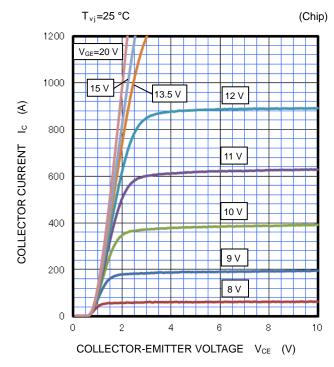
**INSULATED TYPE** 

#### **PERFORMANCE CURVES**

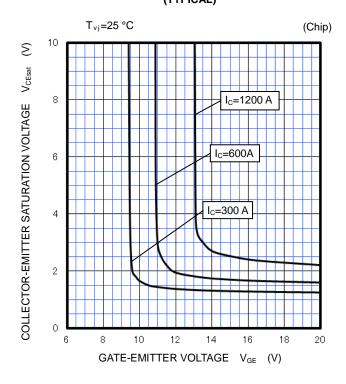
#### **INVERTER PART**

#### **OUTPUT CHARACTERISTICS**

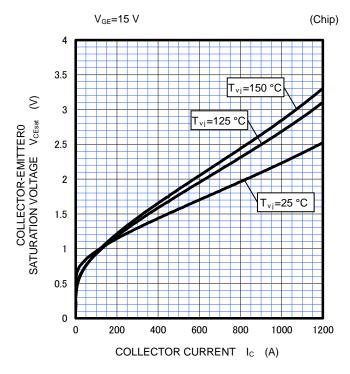
#### (TYPICAL)



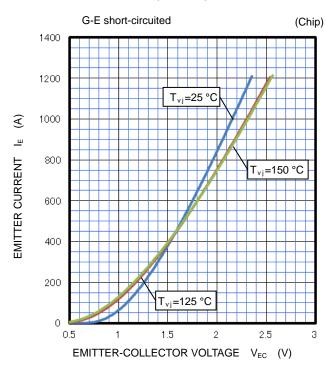
#### COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



#### COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



#### FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



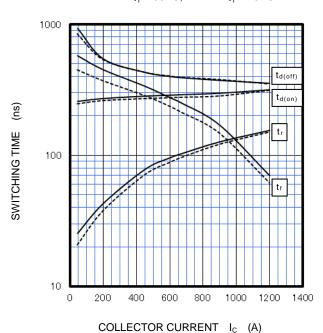
HIGH POWER SWITCHING USE

**INSULATED TYPE** 

#### **PERFORMANCE CURVES**

#### **INVERTER PART**

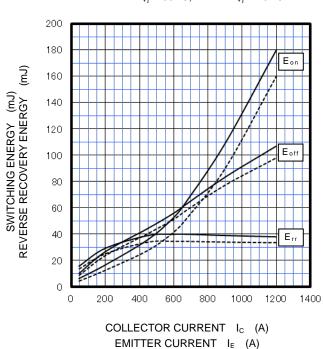
## HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



## HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

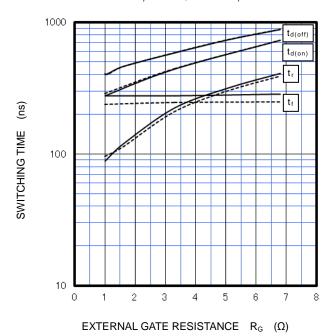
 $V_{CC}$ =600 V,  $V_{GE}$ =±15 V,  $R_{G}$ =1.0  $\Omega$ , INDUCTIVE LOAD, PER PULSE

...:  $T_{vi}$ =150 °C, - - - - :  $T_{vi}$ =125 °C



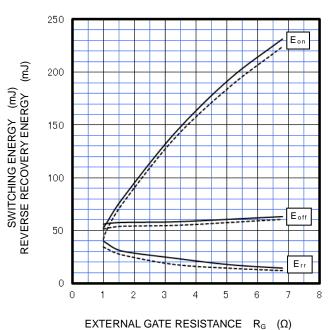
# HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V<sub>CC</sub>=600 V, V<sub>GE</sub>=±15 V, I<sub>C</sub>=600 A, INDUCTIVE LOAD
——: T<sub>vj</sub>=150 °C, - - - - : T<sub>vj</sub>=125 °C



## HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{CC}$ =600 V,  $V_{GE}$ =±15 V,  $I_{C}$ / $I_{E}$ =600 A, INDUCTIVE LOAD, PER PULSE ——:  $T_{vj}$ =150 °C, - - - - :  $T_{vj}$ =125 °C



HIGH POWER SWITCHING USE

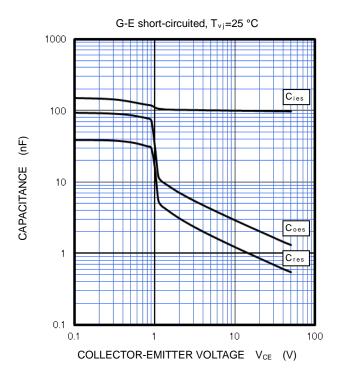
**INSULATED TYPE** 

#### **PERFORMANCE CURVES**

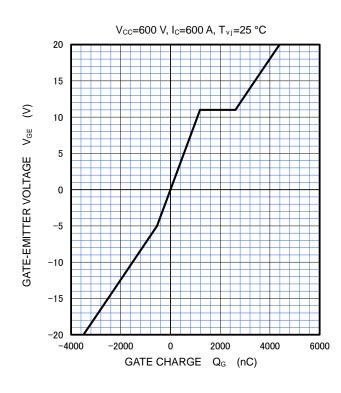
#### **INVERTER PART**

#### **CAPACITANCE CHARACTERISTICS**

#### (TYPICAL)



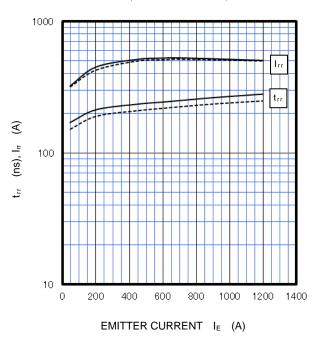
## GATE CHARGE CHARACTERISTICS (TYPICAL)



# FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

 $V_{CC}$ =600 V,  $V_{GE}$ =±15 V,  $R_G$ =1.0  $\Omega$ , INDUCTIVE LOAD

——:  $T_{v_j}$ =150 °C, - - - - :  $T_{v_j}$ =125 °C



## TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

Single pulse,  $T_C=25\ ^{\circ}C$ 

 $R_{th(j-c)Q}=60$  K/kW,  $R_{th(j-c)D}=87$  K/kW 10 NORMALIZED TRANSIENT THERMAL RESISTANCE Z<sub>th (j-c)</sub> 0.1 0.01 Ri [K/kW 0.0124 0.0739 0.3505 0.5632 τί [s] 1.961E-05 0.0014 0.0179 0.0944 0.001

TIME (S)

0.00001 0.0001

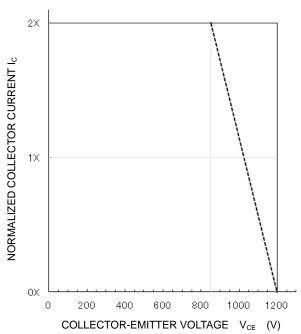
HIGH POWER SWITCHING USE

**INSULATED TYPE** 

#### **PERFORMANCE CURVES**

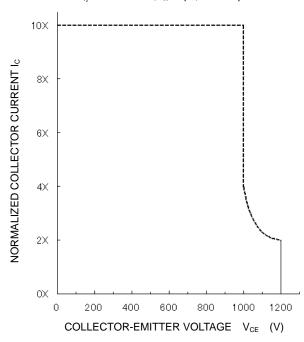
#### **INVERTER PART**

#### TURN-OFF SWITCHING SAFE OPERATING AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)



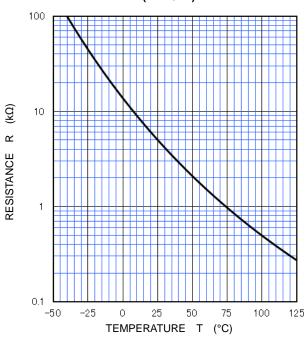
## SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)

 $V_{CC} \le 800 \text{ V}$ ,  $R_G = 1.0 \sim 6.8 \Omega$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $T_{vj} = 25 \sim 150 \text{ °C}$ ,  $t_W \le 8 \mu s$ , Non-Repetitive



#### NTC thermistor part

## TEMPERATURE CHARACTERISTICS (TYPICAL)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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### CM600DX-24T1/CM600DXP-24T1

HIGH POWER SWITCHING USE INSULATED TYPE

### Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them by the reliability lifetime such as Power Cycle, Thermal Cycle or others, or to be used under special circumstances(e.g. high humidity, dusty, salty, highlands, environment with lots of organic matter / corrosive gas / explosive gas, or situation which terminal of semiconductor products is received strong mechanical stress).

In the customer's research and development, please evaluate it not only with a single semiconductor product but also in the entire system, and judge whether it's applicable. Furthermore, trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits (e.g. appropriate fuse or circuit breaker between a power supply and semiconductor products), (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

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